**Product data sheet** 

# 1. General description

Planar passivated Silicon Controlled Rectifier (SCR) module in WeEnPACK-20mm (TO-240AA) for use in applications requiring high blocking voltage capability, high inrush current capability and high thermal cycling performance

## 2. Features and benefits

- · High blocking voltage capability
- · High thermal cycling performance
- · Planar passivated for voltage ruggedness and reliability
- Package meets UL certification
- Package is RoHS compliant
- Industry standard outline
- Soldering pins for PCB mounting
- Copper base plate
- · Cathode Kelvin contacts provided
- UL1557 certified (Document number E346397)

## 3. Applications

- · Softstart AC motor control
- DC Motor control
- · AC power control
- · Power converter
- Temperature control
- Lighting control

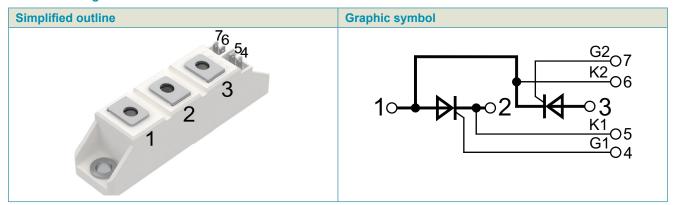
## 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes		Values		Unit
Absolute	maximum rating						
$V_{DRM}$	repetitive peak forward voltage				1600		V
$V_{RRM}$	repetitive peak reverse voltage				1600		V
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave			157		А
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; $T_{J(init)} = 25 \text{ °C}$ ; $t_p = 10 \text{ ms}$			2000		А
		half sine wave; $T_{J(init)}$ = 150 °C; $t_p$ = 10 ms			1600		А
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms		2200		А	
		half sine wave; $T_{J(init)}$ = 150 °C; $t_p$ = 8.3 ms		1800			А
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}$		30	-	100	mA
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}$		-	0.70	1.20	V
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 100 A; T <sub>j</sub> = 25 °C		-	1.15	1.29	V

# 5. Pinning information

**Table 2. Pinning information** 



# 6. Ordering information

**Table 3. Ordering information** 

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WTMH100T16F	WeEnPACK-20mm	WTMH100T16RT	Tray	12	WeEnPACK- 20mmPHB-C	26-Jun-2023

# 7. Marking

## **Table 4. Marking codes**

Type number	Marking codes
WTMH100T16R	WTMH100T16R

# 8. Limiting values

### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
$V_{DRM}$	repetitive peak forward voltage			1600	V
$V_{RRM}$	repetitive peak reverse voltage			1600	V
I <sub>T(AV)</sub>	average on-state current	half sine wave		100	Α
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave		157	Α
I <sub>TSM</sub>	non-repetitive peak onstate	half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 10 ms		2000	Α
	current	half sine wave; $T_{j(init)}$ = 150 °C; $t_p$ = 10 ms		1600	А
		half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 8.3 ms		2200	Α
		half sine wave; $T_{j(init)}$ = 150 °C; $t_p$ = 8.3 ms		1800	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; sine-wave pulse		20	kA²s
dl <sub>⊤</sub> /dt	rate of rise of on-state current	I <sub>G</sub> = 200 mA; T <sub>j</sub> = 150 °C		200	A/µs
I <sub>GM</sub>	peak gate current			10	А
$V_{RGM}$	peak reverse gate voltage			5	V
$P_GM$	peak gate power			20	W
$P_{G(AV)}$	average gate power	over any 20 ms period		0.5	W
$T_{vj}$	virtual junction temperature			-40 to 150	°C
T <sub>op</sub>	operation temperature			-40 to 130	°C
T <sub>stg</sub>	storage temperature			-40 to 130	°C

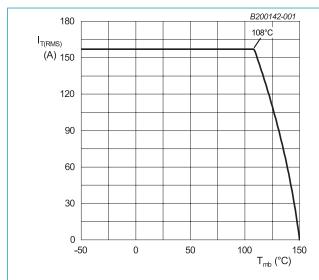


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values

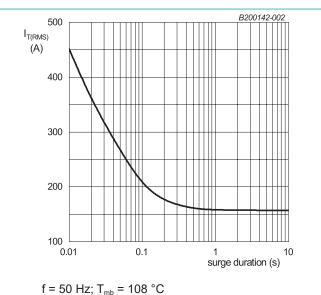


Fig. 2. RMS on-state current as a function of surge duration; maximum values

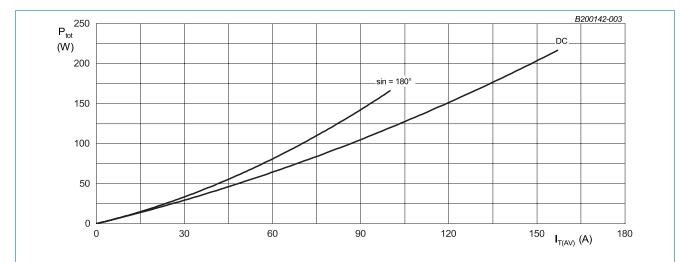
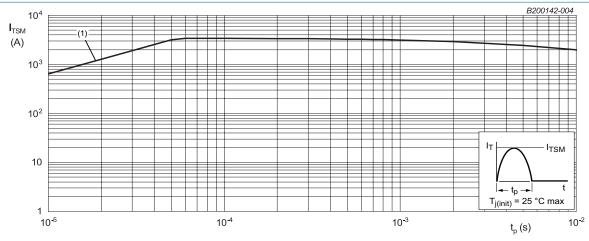


Fig. 3. Total power dissipation as a function of average on-state current; maximum values; per thyristor



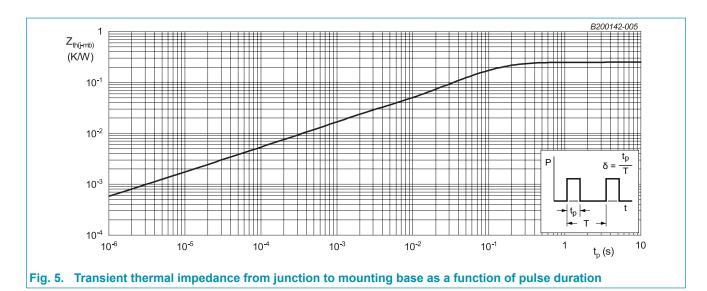
 $t_p \le 10 \text{ ms}$ (1)  $dI_T/dt \text{ limit}$ 

Fig. 4. Non-repetitive peak on-state current as a function of pulse width; maximum values

## 9. Thermal characteristics

#### **Table 6. Thermal characteristics**

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R <sub>th(j-c)</sub>	thermal resistance from junction to case	per thyristor		-	-	0.25	K/W
		per module		-	-	0.125	K/W
R <sub>th(j-h)</sub>	thermal resistance from junction to heatsink	per thyristor		-	-	0.48	K/W
		per module		-	-	0.24	K/W



# 10. Package characteristics

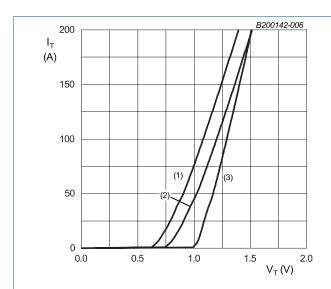
**Table 7. Isolation characteristics** 

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
V <sub>isol</sub> isolation voltag	isolation voltage	50/60 Hz; RMS; $I_{ISOL} \le 1$ mA; t = 1 second; AC		-	-	3600	V
		50/60 Hz; RMS; $I_{ISOL} \le 1$ mA; t = 1 minute; AC		-	-	3000	V

## 11. Characteristics

## Table 8. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}$		30	-	100	mA
$V_{GT}$	gate trigger voltage	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C		-	0.70	1.20	V
		$V_D = 2/3 V_{DRM}$ ; $I_T = 0.1 A$ ; $T_j = 150 °C$		0.25	0.4	-	V
$I_{GD}$	gate non-trigger current	T <sub>j</sub> = 150 °C		-	-	8.5	mA
$V_{GD}$	gate non-trigger voltage	T <sub>j</sub> = 150 °C		-	-	0.2	V
I <sub>L</sub>	latching current	V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C		-	-	300	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C		-	-	200	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 100 A; T <sub>j</sub> = 25 °C		-	-	1.29	V
		I <sub>T</sub> = 200 A; T <sub>j</sub> = 25 °C		-	-	1.51	V
V <sub>TO</sub>	threshold voltage	T <sub>j</sub> = 150 °C		-	-	0.88	V
r <sub>T</sub>	slope resistance	T <sub>j</sub> = 150 °C		-	-	3.2	mΩ
I <sub>D</sub>	off-state current	V <sub>D</sub> = 1600 V; T <sub>j</sub> = 25 °C		-	-	100	μΑ
		V <sub>D</sub> = 1600 V; T <sub>j</sub> = 150 °C		-	-	15	mA
I <sub>R</sub>	reverse current	V <sub>R</sub> = 1600 V; T <sub>j</sub> = 25 °C		-	-	100	μΑ
		V <sub>R</sub> = 1600 V; T <sub>j</sub> = 150 °C		-	-	15	mA
Dynamic	characteristics			l	1		1
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 1072 V; $T_j$ = 150 °C; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; gate open circuit		1500	-	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 40 \text{ A}; V_D = 800 \text{ V}; I_G = 100 \text{ mA};$ $(dI_G/dt)_M = 1 \text{ A/µs}; T_j = 25 ^{\circ}\text{C}$		-	2	-	μs
t <sub>q</sub>	commutated turn-off time	$I_{TM} = 2 \text{ A}; t_p = 50  \mu\text{s};  dV/dt = 5  V/\mu\text{s};$ $dI/dt = 30  A/\mu\text{s}; T_i = 25 ^{\circ}\text{C}$		-	150	-	μs



 $V_{TO} = 0.884 \text{ V}; r_{T} = 0.0032 \Omega$ 

(1) T<sub>j</sub> = 150 °C; typical values (2) T<sub>j</sub> = 150 °C; maximum values

(3) T<sub>i</sub> = 25 °C; maximum values

Fig. 6. On-state current as a function of on-state voltage

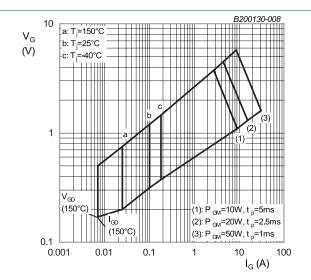
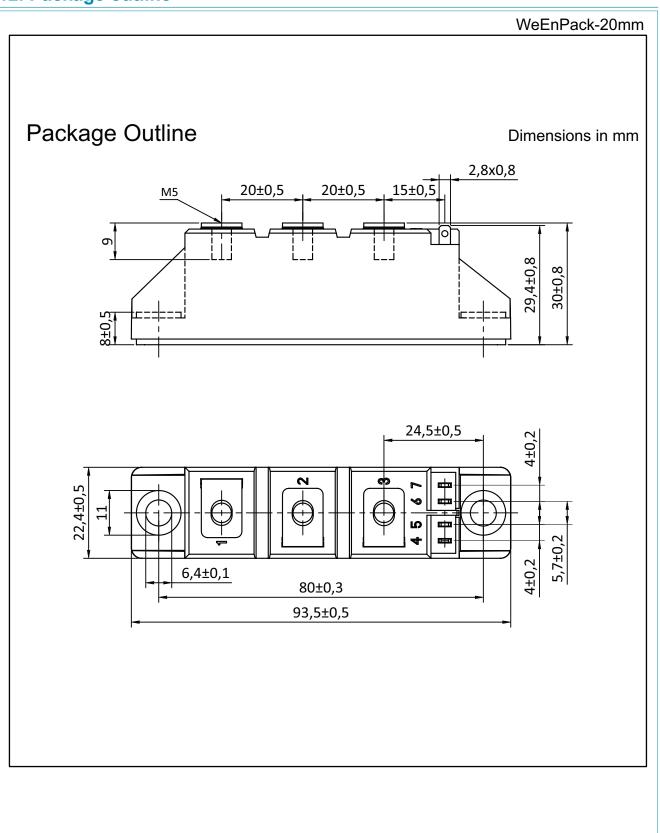


Fig. 7. Gate voltage as a function of gate current

# 12. Package outline



## 13. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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